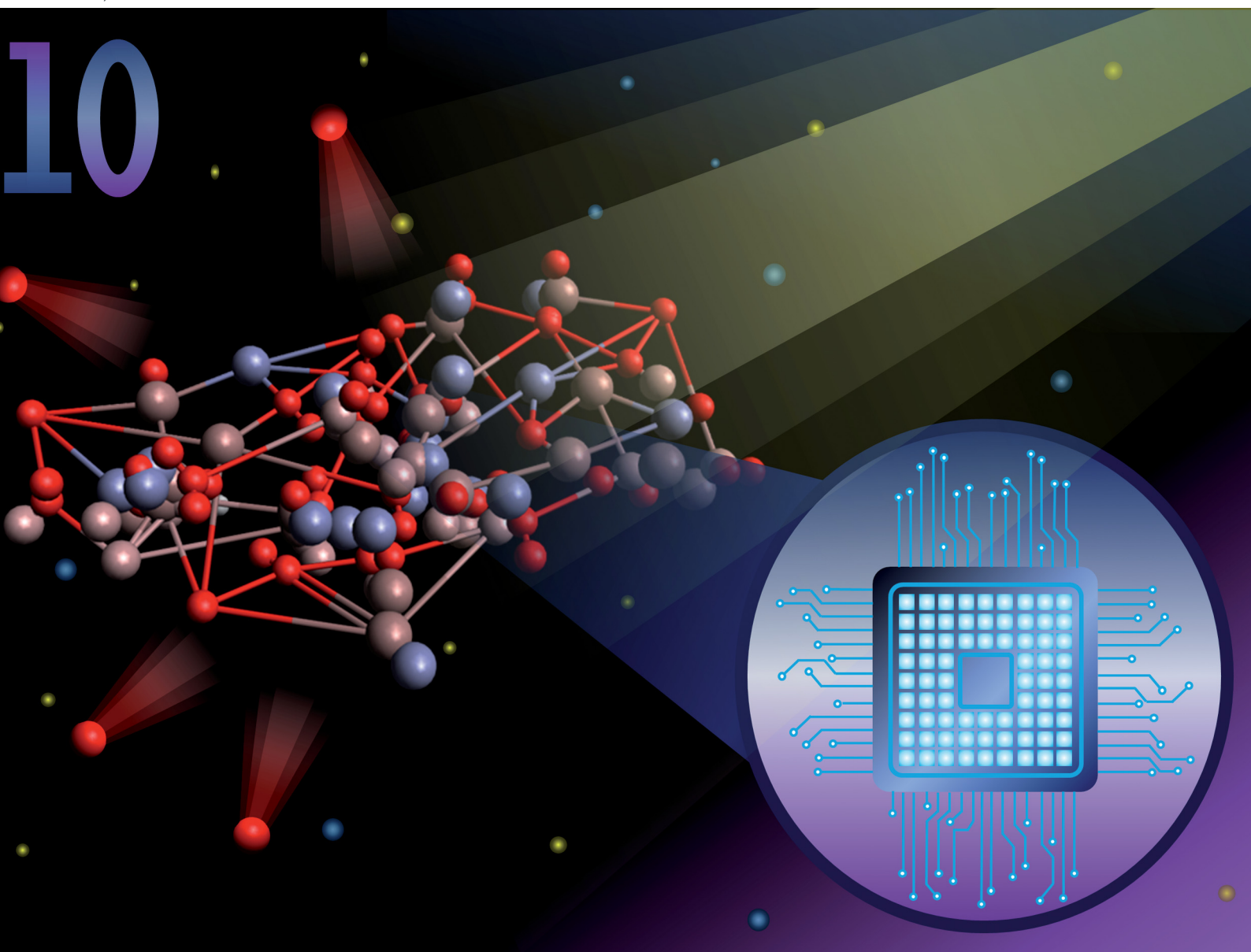


Journal of Materials Chemistry C

Materials for optical, magnetic and electronic devices

rsc.li/materials-c



ISSN 2050-7526

HIGHLIGHT

Youngseok Kim and Choongik Kim
Enhancement of electrical stability of metal oxide thin-film
transistors against various stresses